

# Resource Summary Report

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## JEOL: CRYO ARM 200 Transmission Electron Microscope

RRID:SCR\_020161

Type: Tool

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### Proper Citation

JEOL: CRYO ARM 200 Transmission Electron Microscope (RRID:SCR\_020161)

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### Resource Information

**URL:** <https://www.jeolusa.com/PRODUCTS/Transmission-Electron-Microscopes-TEM/200-kV/CryoARM-200>

**Proper Citation:** JEOL: CRYO ARM 200 Transmission Electron Microscope (RRID:SCR\_020161)

**Description:** Transmission electron microscope that achieves unprecedented resolution and stability allowing for automatic and unattended acquisition of image data for Single Particle Analysis

**Resource Type:** instrument resource

**Keywords:** Jeol, JEOL, Transmission Electron Microscope, Instrument Equipment, USEDit,

**Availability:** Commercially available

**Resource Name:** JEOL: CRYO ARM 200 Transmission Electron Microscope

**Resource ID:** SCR\_020161

**Alternate IDs:** Model\_Number\_CRYO ARM 200

**Record Creation Time:** 20220129T080349+0000

**Record Last Update:** 20260905T132909+0000

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### Ratings and Alerts

No rating or validation information has been found for JEOL: CRYO ARM 200 Transmission Electron Microscope.

No alerts have been found for JEOL: CRYO ARM 200 Transmission Electron Microscope.

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## Data and Source Information

**Source:** [SciCrunch Registry](#)

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## Usage and Citation Metrics

We have not found any literature mentions for this resource.